

#### **Not Intended For New Designs**

August 1992

# 11C06 750 MHz D-Type Flip-Flop

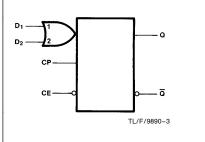
## **General Description**

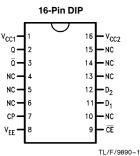
The 11C06 is a high-speed ECL D-Type Master-Slave Flip-Flop capable of toggle rates over 750 MHz. Designed primarily for high-speed prescaling, it can also be used in any application which does not require preset inputs. The circuit is voltage-compensated, which makes input thresholds and

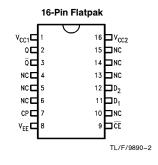
output levels insensitive to  $V_{\mbox{\scriptsize EE}}$  variations. Complementary Q and  $\overline{Q}$  outputs are provided, as are two Data inputs, Clock and Clock Enable inputs. The 11C06 is pin-compatible with the Motorola MC1690L but is a higher-frequency replace-

# **Logic Symbol**

# **Connection Diagrams**







**Truth Table** 

Pin Names	Description				
D <sub>n</sub>	Data Input				
CP	Clock Input				
CE	Clock Enable (Active LOW)				
Q, $\overline{Q}$	Outputs				

CE	СР	D	Q <sub>n</sub>
L	L	Х	$Q_{n-1}$
L	Н	X	$Q_{n-1}$ $Q_{n-1}$
L	_	L	L
L	_	Н	Н
Н	X	Х	$Q_{n-1}$

H = HIGH Voltage Level L = LOW Voltage Level

= Don't Care

= LOW to HIGH Transition

 $Q_{n-1}$  = Previous State

### **Absolute Maximum Ratings**

Above which the useful life may be impaired

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Operating Range  $$-5.7{\rm V}\ {\rm to}\ -4.7{\rm V}$$  Lead Temperature (Soldering, 10 sec.)  $$300^{\circ}{\rm C}$$ 

# Recommended Operating Conditions

 Supply Voltage (V<sub>EE</sub>)
 Min
 Typ
 Max

 -5.7V
 -5.2V
 -4.7V

 Ambient Temperature (T<sub>A</sub>)
 0°C
 +75°C

#### **DC Electrical Characteristics**

 $V_{EE} = -5.2V$ ,  $V_{CC} = GND$ 

Output Current (DC Output HIGH)

Symbol	Parameter	Min	Тур	Max	Units	TA	Conditions
V <sub>OH</sub>	Output Voltage HIGH	-1000		-840	mV	0°C	V <sub>IN</sub> = V <sub>IH (Max)</sub> or V <sub>IL (Min)</sub> per Truth
		-960		-810	mV	+25°C	Table Loading $50\Omega$ to $-2V$
		-900		-720	mV	+75°C	
$V_{OL}$	Output Voltage LOW	-1870		-1635	mV	0°C	
		-1850		-1620	mV	+25°C	
		-1830		−1595	mV	+75°C	
V <sub>OHC</sub>	Output Voltage HIGH	-1020			mV	0°C	$V_{IN} = V_{IH \text{ (Min)}} \text{ or } V_{IL \text{ (Max)}} \text{ for } D_n \text{ Inputs}$
		-980			mV	+25°C	Loading $50\Omega$ to $-2V$
		-920			mV	+75°C	
V <sub>OLC</sub>	Output Voltage LOW			-1615	mV	0°C	
				-1600	mV	+25°C	
				-1575	mV	+75°C	
V <sub>IH</sub>	Input Voltage HIGH	-1135		-840	mV	0°C	Guaranteed Input Voltage HIGH
		-1095		-810	mV	+25°C	for All Inputs
		-1035		-720	mV	+75°C	
$V_{IL}$	Input Voltage LOW	-1870		-1500	mV	0°C	Guaranteed Input Voltage LOW
		-1850		-1485	mV	+25°C	for All Inputs
		-1830		-1460	mV	+75°C	
I <sub>IH</sub>	Input Current HIGH						$V_{IN} = V_{IH (Max)}$
	Clock Input			250	μΑ	+ 25°C	(
	Data Input			270	μΑ	+25°C	
I <sub>IL</sub>	Input Current LOW	0.5			μΑ	+ 25°C	V <sub>IN</sub> = V <sub>IH (Min)</sub>
I <sub>EE</sub>	Power Supply Current	-59	-40		mA	+25°C	All Inputs Open

-50~mA

# **AC Electrical Characteristics**

 $V_{EE} = -5.2V$ ,  $V_{CC} = GND$ ,  $T_A = +25^{\circ}C$ 

Symbol	Parameter	Min	Тур	Max	Units	Conditions
t <sub>PHL</sub> t <sub>PLH</sub>	Propagation Delay (CP-Q) Propagation Delay (CP-Q)	0.7 0.7	1.0 1.0	1.2 1.2	ns ns	
t <sub>TLH</sub> t <sub>THL</sub>	Transition Time 20% to 80% Transition Time 80% to 20%	0.5 0.5	0.8 0.8	1.0 1.0	ns ns	See <i>Figure 1</i>
t <sub>S</sub> Set-up Time           t <sub>H</sub> Hold Time			0.2		ns	
			0.2		ns	
fTOG (MAX)	Toggle Frequency (CP)	650	750		MHz	See Figure 2, Note

# **Functional Description**

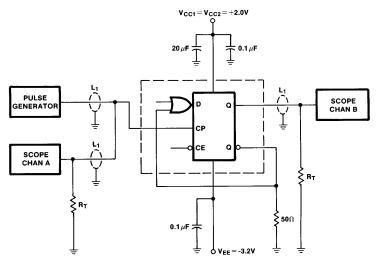
While the clock is LOW, the slave is held steady and the information on the D input is permitted to enter the master. The next transition from LOW to HIGH locks the master in its present state making it insensitive to the D input. This transition simultaneously connects the slave to the master causing the new information to appear on the outputs. Master and slave clock thresholds are internally offset in opposite directions to avoid race conditions or simultaneous

master-slave changes when the clock has slow rise or fall times.

The CP and  $\overline{\text{CE}}$  inputs are logically identical, but physical constraints associated with the Dual-In-Line package make the  $\overline{\text{CE}}$  input slower at the upper end of the toggle range. To prevent new data from entering the master on the next CP LOW cycle,  $\overline{\text{CE}}$  should go HIGH while CP is still HIGH.

TL/F/9890-4

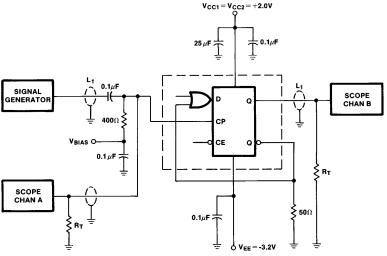
TL/F/9890-5



 $R_{T}\,=\,50\Omega$  termination of scope

 $L_1=50\Omega$  impedance lines All input transition times are 2.0 ns  $\pm 0.2$  ns

FIGURE 1. Propagation Delay (CP to Q)



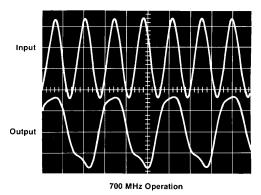
 $R_T = 50\Omega$  termination of scope

 $L_1 = 50\Omega$  impedance lines

Adjust V<sub>BIAS</sub> for  $\pm$  0.7V baseline of 800 mV peak-to-peak sinewave input. All input transition times are 2.0 ns  $\pm$  0.2 ns

FIGURE 2. Toggle Frequency Test Circuit

# **Typical Waveforms**



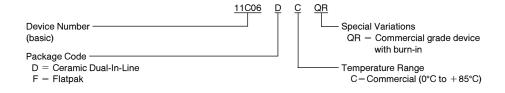
Horizontal Scale = 1.0 ns/div

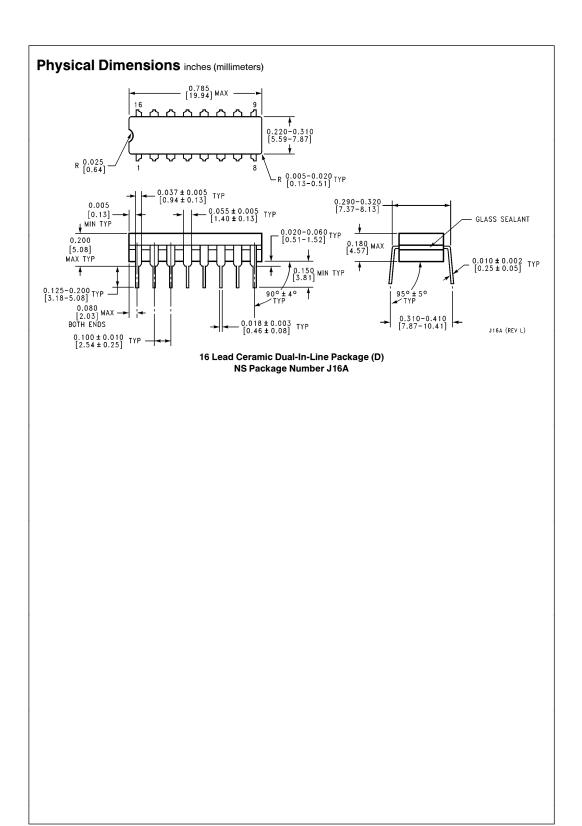
TL/F/9890-6

Horizontal Scale = 1.0 ns/div Vertical Scale = 200 mV/div

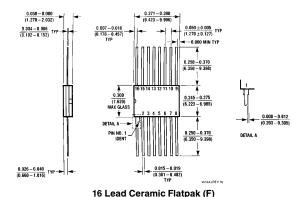
# **Ordering Information**

The device number is used to form part of a simplified purchasing code where the package type and temperature range are defined as follows:





# Physical Dimensions inches (millimeters) (Continued)



NS Package Number W16A

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